

# A O6402A 30V N-Channel MOSFET

## **General Description**

The AO6402A uses advanced trench technology to provide excellent  $R_{\text{DS}(\text{ON})}$  and low gate charge. This device is suitable for use as a load switch or in PWM applications. The source leads are separated to allow a Kelvin connection to the source, which may be used to bypass the source inductance.

## **Product Summary**

 $V_{DS}(V) = 30V$  $I_{D} = 7.5A$ 

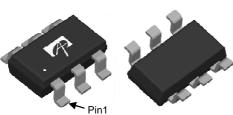
 $(V_{GS} = 10V)$ 

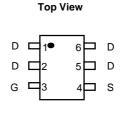
 $R_{DS(ON)} < 24m\Omega$  ( $V_{GS} = 10V$ )

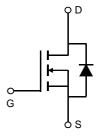
 $R_{DS(ON)} < 35m\Omega$  ( $V_{GS} = 4.5V$ )











Absolute Maximum Ratings T<sub>A</sub>=25℃ unless otherwise noted

Parameter		Symbol	Maximum	Units		
Drain-Source Voltage		$V_{DS}$	30	V		
Gate-Source Voltage		$V_{GS}$	±20	V		
Continuous Drain	T <sub>A</sub> =25℃		7.5			
Current A,F	T <sub>A</sub> =70℃	$I_D$	6.0	Α		
Pulsed Drain Current <sup>B</sup>		I <sub>DM</sub>	64			
	T <sub>A</sub> =25℃	Ь	2.0	W		
Power Dissipation	T <sub>A</sub> =70℃	$-P_D$	1.28	VV		
Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	${\cal C}$		

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient <sup>A</sup>	t ≤ 10s	Os $R_{\theta JA}$		62.5	€\M			
Maximum Junction-to-Ambient <sup>A</sup>	Steady-State	$\kappa_{\theta JA}$	74	110	€\M			
Maximum Junction-to-Lead <sup>C</sup>	Steady-State	$R_{\theta JL}$	54	68	℃/W			

### Electrical Characteristics (T<sub>J</sub>=25℃ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units			
STATIC PARAMETERS									
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$I_D=250\mu A, V_{GS}=0V$	30			V			
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =30V, V <sub>GS</sub> =0V			1	μА			
		T <sub>J</sub> =55℃			5	μΑ			
$I_{GSS}$	Gate-Body leakage current	$V_{DS}$ =0V, $V_{GS}$ = ±20V			100	nA			
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS} I_{D}=250\mu A$	1.5	2.1	2.6	V			
$I_{D(ON)}$	On state drain current	$V_{GS}$ =10V, $V_{DS}$ =5V	64			Α			
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =7.5A		17.3	24	mΩ			
		T <sub>J</sub> =125℃		25	34	11122			
		$V_{GS}$ =4.5V, $I_D$ =5.6A		25	35	mΩ			
g <sub>FS</sub>	Forward Transconductance	$V_{DS}$ =5V, $I_D$ =7.5A		20		S			
$V_{SD}$	Diode Forward Voltage	$I_S=1A, V_{GS}=0V$		0.75	1	V			
Is	Maximum Body-Diode Continuous Current				2.5	Α			
DYNAMIC	PARAMETERS								
C <sub>iss</sub>	Input Capacitance			373	448	pF			
C <sub>oss</sub>	Output Capacitance	$V_{GS}$ =0V, $V_{DS}$ =15V, f=1MHz		67		pF			
$C_{rss}$	Reverse Transfer Capacitance			41		pF			
$R_g$	Gate resistance	$V_{GS}$ =0V, $V_{DS}$ =0V, f=1MHz		2	2.8	Ω			
SWITCHI	NG PARAMETERS								
Q <sub>g</sub> (10V)	Total Gate Charge			7.2	11	nC			
Q <sub>g</sub> (4.5V)	Total Gate Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, I <sub>D</sub> =7.5A		3.5	5	nC			
$Q_{gs}$	Gate Source Charge	V <sub>GS</sub> -10V, V <sub>DS</sub> -13V, I <sub>D</sub> -7.3A		1.3		nC			
$Q_{gd}$	Gate Drain Charge	1		1.7		nC			
t <sub>D(on)</sub>	Turn-On DelayTime			4.5	6.5	ns			
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =10V, $V_{DS}$ =15V, $R_L$ =2 $\Omega$ ,		2.7	4.5	ns			
$t_{D(off)}$	Turn-Off DelayTime	$R_{GEN}=3\Omega$		14.9	23	ns			
t <sub>f</sub>	Turn-Off Fall Time	]		2.9	5.5	ns			
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =7.5A, dI/dt=100A/μs		10.5	12.6	ns			
$Q_{rr}$	Body Diode Reverse Recovery Charge	I <sub>F</sub> =7.5A, dI/dt=100A/μs		4.5	5.4	nC			

A: The value of R  $_{\theta JA}$  is measured with the device mounted on 1 in  $^2$  FR-4 board with 2oz. Copper, in a still air environment with T  $_A$ =25 $^\circ$  C. The value in any given application depends on the user's specific board design. The current rating is based on the  $t \le 10s$  thermal resistance rating. B: Repetitive rating, pulse width limited by junction temperature.

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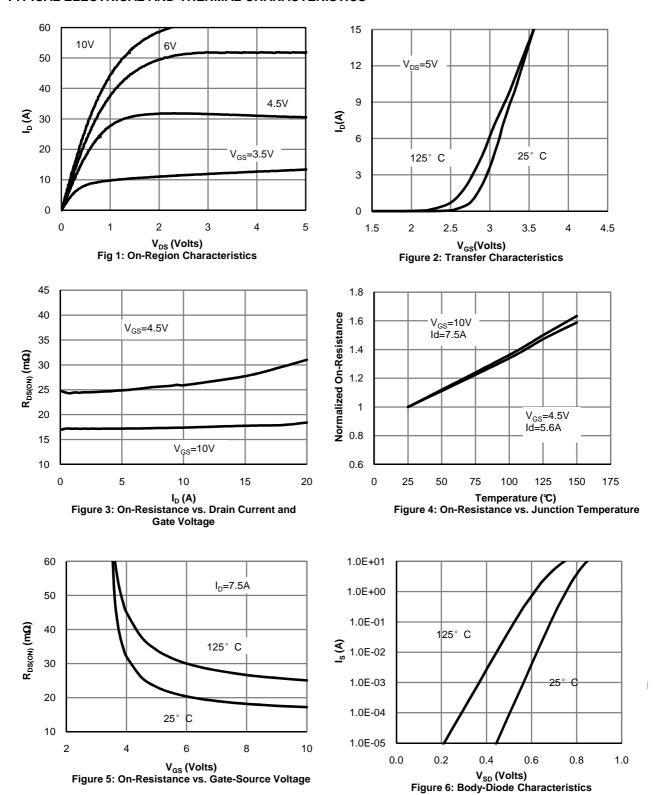
C. The R  $_{\theta JA}$  is the sum of the thermal impedence from junction to lead R  $_{\theta JL}$  and lead to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using <300 µs pulses, duty cycle 0.5% max.

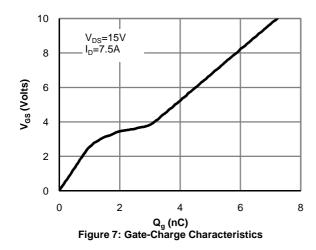
E. These tests are performed with the device mounted on 1 in <sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T <sub>A</sub>=25° C. The SOA curve provides a single pulse rating.

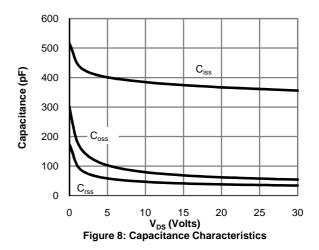
F.The current rating is based on the  $t \le 10s$  thermal resistance rating.

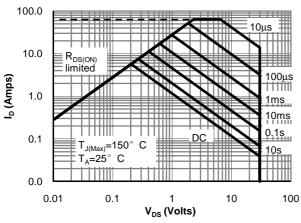
### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



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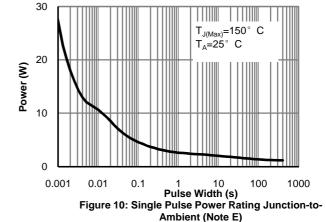


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

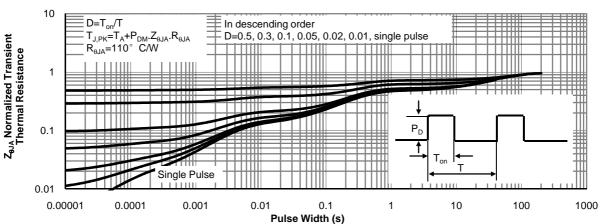
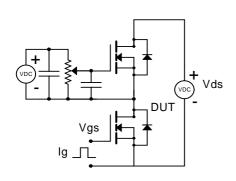
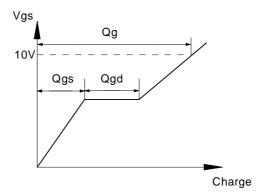


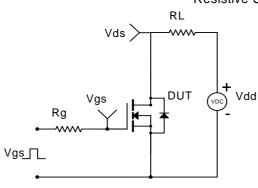
Figure 11: Normalized Maximum Transient Thermal Impedance

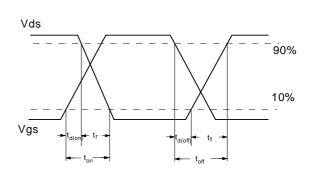
## Gate Charge Test Circuit & Waveform





Resistive Switching Test Circuit & Waveforms





## Diode Recovery Test Circuit & Waveforms

